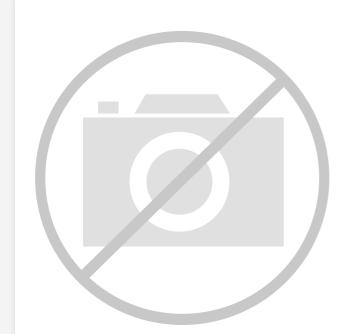
E·XFL

AMD Xilinx - XC2S15-5CS144I Datasheet



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Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

| Details | |
|--------------------------------|--|
| Product Status | Obsolete |
| Number of LABs/CLBs | 96 |
| Number of Logic Elements/Cells | 432 |
| Total RAM Bits | 16384 |
| Number of I/O | 86 |
| Number of Gates | 15000 |
| Voltage - Supply | 2.375V ~ 2.625V |
| Mounting Type | Surface Mount |
| Operating Temperature | -40°C ~ 100°C (TJ) |
| Package / Case | 144-TFBGA, CSPBGA |
| Supplier Device Package | 144-LCSBGA (12x12) |
| Purchase URL | https://www.e-xfl.com/product-detail/xilinx/xc2s15-5cs144i |
| | |

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General Overview

The Spartan-II family of FPGAs have a regular, flexible, programmable architecture of Configurable Logic Blocks (CLBs), surrounded by a perimeter of programmable Input/Output Blocks (IOBs). There are four Delay-Locked Loops (DLLs), one at each corner of the die. Two columns of block RAM lie on opposite sides of the die, between the CLBs and the IOB columns. These functional elements are interconnected by a powerful hierarchy of versatile routing channels (see Figure 1).

Spartan-II FPGAs are customized by loading configuration data into internal static memory cells. Unlimited reprogramming cycles are possible with this approach. Stored values in these cells determine logic functions and interconnections implemented in the FPGA. Configuration data can be read from an external serial PROM (master serial mode), or written into the FPGA in slave serial, slave parallel, or Boundary Scan modes.

Spartan-II FPGAs are typically used in high-volume applications where the versatility of a fast programmable solution adds benefits. Spartan-II FPGAs are ideal for shortening product development cycles while offering a cost-effective solution for high volume production.

Spartan-II FPGAs achieve high-performance, low-cost operation through advanced architecture and semiconductor technology. Spartan-II devices provide system clock rates up to 200 MHz. In addition to the conventional benefits of high-volume programmable logic solutions, Spartan-II FPGAs also offer on-chip synchronous single-port and dual-port RAM (block and distributed form), DLL clock drivers, programmable set and reset on all flip-flops, fast carry logic, and many other features.

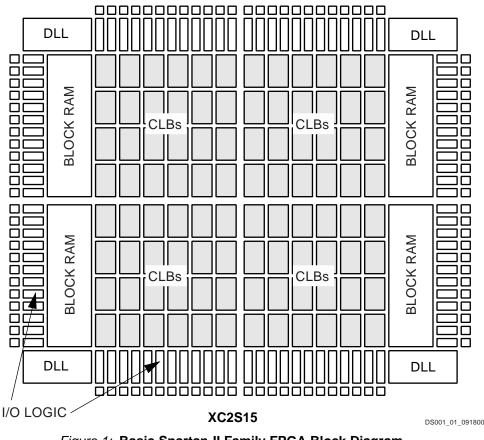


Figure 1: Basic Spartan-II Family FPGA Block Diagram

DS001-2 (v2.8) June 13, 2008

Architectural Description

Spartan-II FPGA Array

The Spartan[®]-II field-programmable gate array, shown in Figure 2, is composed of five major configurable elements:

- IOBs provide the interface between the package pins and the internal logic
- CLBs provide the functional elements for constructing most logic
- Dedicated block RAM memories of 4096 bits each
- Clock DLLs for clock-distribution delay compensation and clock domain control
- Versatile multi-level interconnect structure

As can be seen in Figure 2, the CLBs form the central logic structure with easy access to all support and routing structures. The IOBs are located around all the logic and

Spartan-II FPGA Family: Functional Description

Product Specification

memory elements for easy and quick routing of signals on and off the chip.

Values stored in static memory cells control all the configurable logic elements and interconnect resources. These values load into the memory cells on power-up, and can reload if necessary to change the function of the device.

Each of these elements will be discussed in detail in the following sections.

Input/Output Block

The Spartan-II FPGA IOB, as seen in Figure 2, features inputs and outputs that support a wide variety of I/O signaling standards. These high-speed inputs and outputs are capable of supporting various state of the art memory and bus interfaces. Table 3 lists several of the standards which are supported along with the required reference, output and termination voltages needed to meet the standard.

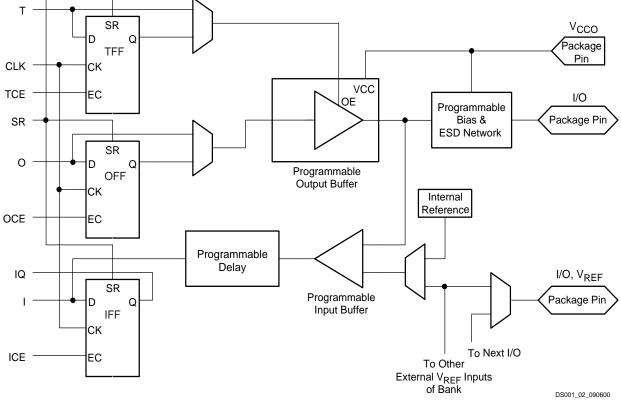


Figure 2: Spartan-II FPGA Input/Output Block (IOB)

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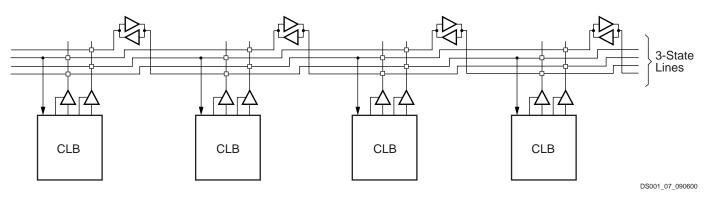


Figure 7: BUFT Connections to Dedicated Horizontal Bus Lines

Clock Distribution

The Spartan-II family provides high-speed, low-skew clock distribution through the primary global routing resources described above. A typical clock distribution net is shown in Figure 8.

Four global buffers are provided, two at the top center of the device and two at the bottom center. These drive the four primary global nets that in turn drive any clock pin.

Four dedicated clock pads are provided, one adjacent to each of the global buffers. The input to the global buffer is selected either from these pads or from signals in the general purpose routing. Global clock pins do not have the option for internal, weak pull-up resistors.

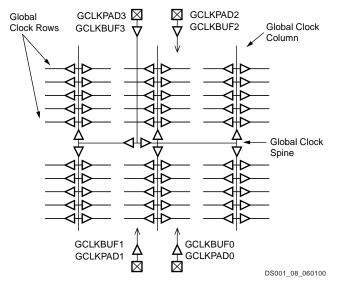


Figure 8: Global Clock Distribution Network

Delay-Locked Loop (DLL)

Associated with each global clock input buffer is a fully digital Delay-Locked Loop (DLL) that can eliminate skew between the clock input pad and internal clock-input pins throughout the device. Each DLL can drive two global clock networks. The DLL monitors the input clock and the distributed clock, and automatically adjusts a clock delay element. Additional delay is introduced such that clock edges reach internal flip-flops exactly one clock period after they arrive at the input. This closed-loop system effectively eliminates clock-distribution delay by ensuring that clock edges arrive at internal flip-flops in synchronism with clock edges arriving at the input.

In addition to eliminating clock-distribution delay, the DLL provides advanced control of multiple clock domains. The DLL provides four quadrature phases of the source clock, can double the clock, or divide the clock by 1.5, 2, 2.5, 3, 4, 5, 8, or 16. It has six outputs.

The DLL also operates as a clock mirror. By driving the output from a DLL off-chip and then back on again, the DLL can be used to deskew a board level clock among multiple Spartan-II devices.

In order to guarantee that the system clock is operating correctly prior to the FPGA starting up after configuration, the DLL can delay the completion of the configuration process until after it has achieved lock.

Boundary Scan

Spartan-II devices support all the mandatory boundaryscan instructions specified in the IEEE standard 1149.1. A Test Access Port (TAP) and registers are provided that implement the EXTEST, SAMPLE/PRELOAD, and BYPASS instructions. The TAP also supports two USERCODE instructions and internal scan chains.

The TAP uses dedicated package pins that always operate using LVTTL. For TDO to operate using LVTTL, the V_{CCO} for Bank 2 must be 3.3V. Otherwise, TDO switches rail-to-rail between ground and V_{CCO}. TDI, TMS, and TCK have a default internal weak pull-up resistor, and TDO has no default resistor. Bitstream options allow setting any of the four TAP pins to have an internal pull-up, pull-down, or neither.

Boundary-scan operation is independent of individual IOB configurations, and unaffected by package type. All IOBs, including unbonded ones, are treated as independent 3-state bidirectional pins in a single scan chain. Retention of the bidirectional test capability after configuration facilitates the testing of external interconnections.

Table 7 lists the boundary-scan instructions supported in Spartan-II FPGAs. Internal signals can be captured during EXTEST by connecting them to unbonded or unused IOBs. They may also be connected to the unused outputs of IOBs defined as unidirectional input pins.

| Boundary-Scan Command | Binary Code[4:0] | Description |
|--------------------------|---------------------|---|
| EXTEST | 00000 | Enables boundary-scan EXTEST operation |
| SAMPLE | 00001 | Enables boundary-scan SAMPLE operation |
| USR1 | 00010 | Access user-defined register 1 |
| USR2 | 00011 | Access user-defined register 2 |
| CFG_OUT | 00100 | Access the configuration bus for Readback |
| CFG_IN | 00101 | Access the configuration bus for Configuration |
| INTEST | 00111 | Enables boundary-scan INTEST operation |
| USRCODE | 01000 | Enables shifting out USER code |
| IDCODE | 01001 | Enables shifting out of ID Code |
| HIZ | 01010 | Disables output pins while enabling the Bypass Register |
| JSTART | 01100 | Clock the start-up sequence when StartupClk is TCK |
| BYPASS | 11111 | Enables BYPASS |
| RESERVED | All other codes | Xilinx [®] reserved instructions |

Table 7: Boundary-Scan Instructions

The public boundary-scan instructions are available prior to configuration. After configuration, the public instructions remain available together with any USERCODE instructions installed during the configuration. While the SAMPLE and BYPASS instructions are available during configuration, it is recommended that boundary-scan operations not be performed during this transitional period.

In addition to the test instructions outlined above, the boundary-scan circuitry can be used to configure the FPGA, and also to read back the configuration data.

To facilitate internal scan chains, the User Register provides three outputs (Reset, Update, and Shift) that represent the corresponding states in the boundary-scan internal state machine.

Master Serial Mode

In Master Serial mode, the CCLK output of the FPGA drives a Xilinx PROM which feeds a serial stream of configuration data to the FPGA's DIN input. Figure 15 shows a Master Serial FPGA configuring a Slave Serial FPGA from a PROM. A Spartan-II device in Master Serial mode should be connected as shown for the device on the left side. Master Serial mode is selected by a <00x> on the mode pins (M0, M1, M2). The PROM RESET pin is driven by INIT, and CE input is driven by DONE. The interface is identical to the slave serial mode except that an oscillator internal to the FPGA is used to generate the configuration clock (CCLK). Any of a number of different frequencies ranging from 4 to 60 MHz can be set using the ConfigRate option in the Xilinx software. On power-up, while the first 60 bytes of the configuration data are being loaded, the CCLK frequency is always 2.5 MHz. This frequency is used until the ConfigRate bits, part of the configuration file, have been loaded into the FPGA, at which point, the frequency changes to the selected ConfigRate. Unless a different frequency is specified in the design, the default ConfigRate is 4 MHz. The frequency of the CCLK signal created by the internal oscillator has a variance of +45%, -30% from the specified value.

Figure 17 shows the timing for Master Serial configuration. The FPGA accepts one bit of configuration data on each rising CCLK edge. After the FPGA has been loaded, the data for the next device in a daisy-chain is presented on the DOUT pin after the rising CCLK edge.

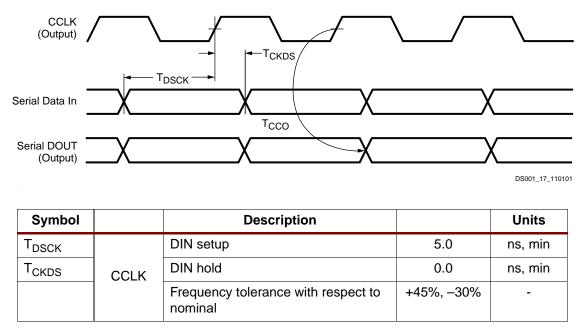


Figure 17: Master Serial Mode Timing

Slave Parallel Mode

The Slave Parallel mode is the fastest configuration option. Byte-wide data is written into the FPGA. A BUSY flag is provided for controlling the flow of data at a clock frequency F_{CCNH} above 50 MHz.

Figure 18, page 24 shows the connections for two Spartan-II devices using the Slave Parallel mode. Slave Parallel mode is selected by a <011> on the mode pins (M0, M1, M2).

If a configuration file of the format .bit, .rbt, or non-swapped HEX is used for parallel programming, then the most significant bit (i.e. the left-most bit of each configuration byte, as displayed in a text editor) must be routed to the D0 input on the FPGA. The agent controlling configuration is not shown. Typically, a processor, a microcontroller, or CPLD controls the Slave Parallel interface. The controlling agent provides byte-wide configuration data, CCLK, a Chip Select (\overline{CS}) signal and a Write signal (WRITE). If BUSY is asserted (High) by the FPGA, the data must be held until BUSY goes Low.

After configuration, the pins of the Slave Parallel port (D0-D7) can be used as additional user I/O. Alternatively, the port may be retained to permit high-speed 8-bit readback. Then data can be read by de-asserting WRITE. See "Readback," page 25.

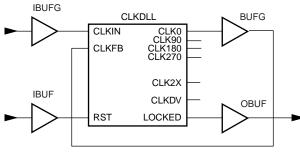
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Useful Application Examples

The Spartan-II FPGA DLL can be used in a variety of creative and useful applications. The following examples show some of the more common applications.

Standard Usage

The circuit shown in Figure 28 resembles the BUFGDLL macro implemented to provide access to the RST and LOCKED pins of the CLKDLL.

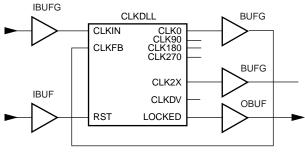


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Figure 28: Standard DLL Implementation

Deskew of Clock and Its 2x Multiple

The circuit shown in Figure 29 implements a 2x clock multiplier and also uses the CLK0 clock output with zero ns skew between registers on the same chip. A clock divider circuit could alternatively be implemented using similar connections.



DS001_29_061200

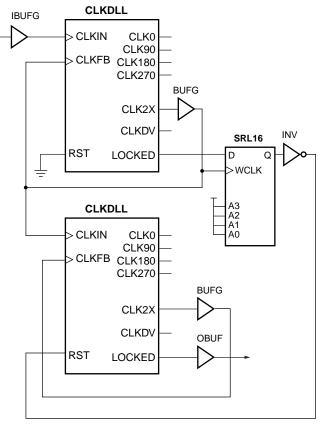
Figure 29: DLL Deskew of Clock and 2x Multiple

Because any single DLL can only access at most two BUFGs, any additional output clock signals must be routed from the DLL in this example on the high speed backbone routing.

Generating a 4x Clock

By connecting two DLL circuits each implementing a 2x clock multiplier in series as shown in Figure 30, a 4x clock multiply can be implemented with zero skew between registers in the same device.

If other clock output is needed, the clock could access a BUFG only if the DLLs are constrained to exist on opposite edges (Top or Bottom) of the device.



DS001_30_061200

Figure 30: DLL Generation of 4x Clock

When using this circuit it is vital to use the SRL16 cell to reset the second DLL after the initial chip reset. If this is not done, the second DLL may not recognize the change of frequencies from when the input changes from a 1x (25/75) waveform to a 2x (50/50) waveform. It is not recommended to cascade more than two DLLs.

For design examples and more information on using the DLL, see <u>XAPP174</u>, Using Delay-Locked Loops in Spartan-II FPGAs.

Table 11: Available Library Primitives

| Primitive | Port A Width | Port B Width |
|---|--------------|----------------------|
| RAMB4_S4 RAMB4_S4_S4 RAMB4_S4_S8 RAMB4_S4_S16 | 4 | N/A 4 8 |
| RAMB4_S4_S16 RAMB4_S8 RAMB4_S8_S8 RAMB4_S8_S16 | 8 | 16 N/A 8 16 |
| RAMB4_S16 RAMB4_S16_S16 | 16 | N/A 16 |

Port Signals

Each block RAM port operates independently of the others while accessing the same set of 4096 memory cells.

 Table 12 describes the depth and width aspect ratios for the block RAM memory.

Table 12: Block RAM Port Aspect Ratios

| Width | Depth | ADDR Bus | Data Bus |
|-------|-------|------------|------------|
| 1 | 4096 | ADDR<11:0> | DATA<0> |
| 2 | 2048 | ADDR<10:0> | DATA<1:0> |
| 4 | 1024 | ADDR<9:0> | DATA<3:0> |
| 8 | 512 | ADDR<8:0> | DATA<7:0> |
| 16 | 256 | ADDR<7:0> | DATA<15:0> |

Clock—CLK[A/B]

Each port is fully synchronous with independent clock pins. All port input pins have setup time referenced to the port CLK pin. The data output bus has a clock-to-out time referenced to the CLK pin.

Enable—EN[A/B]

The enable pin affects the read, write and reset functionality of the port. Ports with an inactive enable pin keep the output pins in the previous state and do not write data to the memory cells.

Write Enable—WE[A/B]

Activating the write enable pin allows the port to write to the memory cells. When active, the contents of the data input bus are written to the RAM at the address pointed to by the address bus, and the new data also reflects on the data out bus. When inactive, a read operation occurs and the contents of the memory cells referenced by the address bus reflect on the data out bus.

Reset—RST[A|B]

The reset pin forces the data output bus latches to zero synchronously. This does not affect the memory cells of the RAM and does not disturb a write operation on the other port.

Address Bus—ADDR[A/B]<#:0>

The address bus selects the memory cells for read or write. The width of the port determines the required width of this bus as shown in Table 12.

Data In Bus-DI[A/B]<#:0>

The data in bus provides the new data value to be written into the RAM. This bus and the port have the same width, as shown in Table 12.

Data Output Bus—DO[A/B]<#:0>

The data out bus reflects the contents of the memory cells referenced by the address bus at the last active clock edge. During a write operation, the data out bus reflects the data in bus. The width of this bus equals the width of the port. The allowed widths appear in Table 12.

Inverting Control Pins

The four control pins (CLK, EN, WE and RST) for each port have independent inversion control as a configuration option.

Address Mapping

Each port accesses the same set of 4096 memory cells using an addressing scheme dependent on the width of the port. The physical RAM location addressed for a particular width are described in the following formula (of interest only when the two ports use different aspect ratios).

Table 13 shows low order address mapping for each portwidth.

Table 13: Port Address Mapping

| Port Widt h | Port Addresses | | | | | | | | | | | | | | | | |
|-------------------|-------------------|--------|--------|--------|----------|--------|--------|--------|--------|--------|--------|--------|--------|--------|--------|--------|--------|
| 1 | 4095 | 1 5 | 1 4 | 1 3 | 1 2 | 1 1 | 1 0 | 0 9 | 0 8 | 0 7 | 0 6 | 0 5 | 0 4 | 0 3 | 0 2 | 0 1 | 0 0 |
| 2 | 2047 | 0 | 07 06 | | 05 04 | | 03 02 | | 2 | 01 | | 00 | | | | | |
| 4 | 1023 | 03 | | | 03 02 01 | | 01 00 | | 0 | | | | | | | | |
| 8 | 511 | | 01 | | | | | | | | 0 | 0 | | | | | |
| 16 | 255 | | | | | | | | 0 | 0 | | | | | | | |

support of a wide variety of applications, from general purpose standard applications to high-speed low-voltage memory busses.

Versatile I/O blocks also provide selectable output drive strengths and programmable slew rates for the LVTTL output buffers, as well as an optional, programmable weak pull-up, weak pull-down, or weak "keeper" circuit ideal for use in external bussing applications.

Each Input/Output Block (IOB) includes three registers, one each for the input, output, and 3-state signals within the IOB. These registers are optionally configurable as either a D-type flip-flop or as a level sensitive latch.

The input buffer has an optional delay element used to guarantee a zero hold time requirement for input signals registered within the IOB.

The Versatile I/O features also provide dedicated resources for input reference voltage (V_{REF}) and output source voltage (V_{CCO}), along with a convenient banking system that simplifies board design.

By taking advantage of the built-in features and wide variety of I/O standards supported by the Versatile I/O features, system-level design and board design can be greatly simplified and improved.

Fundamentals

Modern bus applications, pioneered by the largest and most influential companies in the digital electronics industry, are commonly introduced with a new I/O standard tailored specifically to the needs of that application. The bus I/O standards provide specifications to other vendors who create products designed to interface with these applications. Each standard often has its own specifications for current, voltage, I/O buffering, and termination techniques.

The ability to provide the flexibility and time-to-market advantages of programmable logic is increasingly dependent on the capability of the programmable logic device to support an ever increasing variety of I/O standards

The Versatile I/O resources feature highly configurable input and output buffers which provide support for a wide variety of I/O standards. As shown in Table 15, each buffer type can support a variety of voltage requirements.

Table 15: Versatile I/O Supported Standards (Typical Values)

| , | | | | | | | | | | |
|-------------------------------|--|--|---|--|--|--|--|--|--|--|
| I/O Standard | Input Reference Voltage (V _{REF}) | Output Source Voltage (V _{CCO}) | Board Termination Voltage (V _{TT}) | | | | | | | |
| LVTTL (2-24 mA) | N/A | 3.3 | N/A | | | | | | | |
| LVCMOS2 | N/A | 2.5 | N/A | | | | | | | |
| PCI (3V/5V, 33 MHz/66 MHz) | N/A | 3.3 | N/A | | | | | | | |
| GTL | 0.8 | N/A | 1.2 | | | | | | | |
| GTL+ | 1.0 | N/A | 1.5 | | | | | | | |
| HSTL Class I | 0.75 | 1.5 | 0.75 | | | | | | | |
| HSTL Class III | 0.9 | 1.5 | 1.5 | | | | | | | |
| HSTL Class IV | 0.9 | 1.5 | 1.5 | | | | | | | |
| SSTL3 Class I and II | 1.5 | 3.3 | 1.5 | | | | | | | |
| SSTL2 Class I and II | 1.25 | 2.5 | 1.25 | | | | | | | |
| CTT | 1.5 | 3.3 | 1.5 | | | | | | | |
| AGP-2X | 1.32 | 3.3 | N/A | | | | | | | |

Overview of Supported I/O Standards

This section provides a brief overview of the I/O standards supported by all Spartan-II devices.

While most I/O standards specify a range of allowed voltages, this document records typical voltage values only. Detailed information on each specification may be found on the Electronic Industry Alliance JEDEC website at http://www.jedec.org. For more details on the I/O standards and termination application examples, see XAPP179, "Using SelectIO Interfaces in Spartan-II and Spartan-IIE FPGAs."

LVTTL — Low-Voltage TTL

The Low-Voltage TTL (LVTTL) standard is a general purpose EIA/JESDSA standard for 3.3V applications that uses an LVTTL input buffer and a Push-Pull output buffer. This standard requires a 3.3V output source voltage (V_{CCO}), but does not require the use of a reference voltage (V_{REF}) or a termination voltage (V_{TT}).

LVCMOS2 — Low-Voltage CMOS for 2.5V

The Low-Voltage CMOS for 2.5V or lower (LVCMOS2) standard is an extension of the LVCMOS standard (JESD 8.5) used for general purpose 2.5V applications. This standard requires a 2.5V output source voltage (V_{CCO}), but does not require the use of a reference voltage (V_{REF}) or a board termination voltage (V_{TT}).

LVTTL output buffers have selectable drive strengths.

The format for LVTTL OBUF primitive names is as follows.

OBUF <slew rate> <drive strength>

<slew_rate> is either F (Fast), or S (Slow) and <drive_strength> is specified in milliamps (2, 4, 6, 8, 12, 16, or 24). The default is slew rate limited with 12 mA drive.

OBUF placement restrictions require that within a given V_{CCO} bank each OBUF share the same output source drive voltage. Input buffers of any type and output buffers that do not require V_{CCO} can be placed within any V_{CCO} bank. Table 17 summarizes the output compatibility requirements. The LOC property can specify a location for the OBUF.

Table 17: Output Standards Compatibility Requirements

| Rule 1 | Only outputs with standards which share compatible $\rm V_{\rm CCO}$ may be used within the same bank. |
|------------------|---|
| Rule 2 | There are no placement restrictions for outputs with standards that do not require a $\rm V_{\rm CCO}.$ |
| V _{CCO} | Compatible Standards |
| 3.3 | LVTTL, SSTL3_I, SSTL3_II, CTT, AGP, GTL, GTL+, PCI33_3, PCI66_3 |
| 2.5 | SSTL2_I, SSTL2_II, LVCMOS2, GTL, GTL+ |
| 1.5 | HSTL_I, HSTL_III, HSTL_IV, GTL, GTL+ |

OBUFT

The generic 3-state output buffer OBUFT, shown in Figure 39, typically implements 3-state outputs or bidirectional I/O.

With no extension or property specified for the generic OBUFT primitive, the assumed standard is slew rate limited LVTTL with 12 mA drive strength.

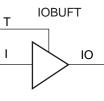
The LVTTL OBUFT can support one of two slew rate modes to minimize bus transients. By default, the slew rate for each output buffer is reduced to minimize power bus transients when switching non-critical signals.

LVTTL 3-state output buffers have selectable drive strengths.

The format for LVTTL OBUFT primitive names is as follows.

OBUFT_<slew_rate>_<drive_strength>

<slew_rate> can be either F (Fast), or S (Slow) and <drive_strength> is specified in milliamps (2, 4, 6, 8, 12, 16, or 24).



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Figure 39: 3-State Output Buffer Primitive (OBUFT

The Versatile I/O OBUFT placement restrictions require that within a given V_{CCO} bank each OBUFT share the same output source drive voltage. Input buffers of any type and output buffers that do not require V_{CCO} can be placed within the same V_{CCO} bank.

The LOC property can specify a location for the OBUFT.

3-state output buffers and bidirectional buffers can have either a weak pull-up resistor, a weak pull-down resistor, or a weak "keeper" circuit. Control this feature by adding the appropriate primitive to the output net of the OBUFT (PULLUP, PULLDOWN, or KEEPER).

The weak "keeper" circuit requires the input buffer within the IOB to sample the I/O signal. So, OBUFTs programmed for an I/O standard that requires a V_{REF} have automatic placement of a V_{REF} in the bank with an OBUFT configured with a weak "keeper" circuit. This restriction does not affect most circuit design as applications using an OBUFT configured with a weak "keeper" typically implement a bidirectional I/O. In this case the IBUF (and the corresponding V_{REF}) are explicitly placed.

The LOC property can specify a location for the OBUFT.

IOBUF

Use the IOBUF primitive for bidirectional signals that require both an input buffer and a 3-state output buffer with an active high 3-state pin. The generic input/output buffer IOBUF appears in Figure 40.

With no extension or property specified for the generic IOBUF primitive, the assumed standard is LVTTL input buffer and slew rate limited LVTTL with 12 mA drive strength for the output buffer.

The LVTTL IOBUF can support one of two slew rate modes to minimize bus transients. By default, the slew rate for each output buffer is reduced to minimize power bus transients when switching non-critical signals.

LVTTL bidirectional buffers have selectable output drive strengths.

The format for LVTTL IOBUF primitive names is as follows:

property. This property could have one of the following seven values.

DRIVE=2 DRIVE=4 DRIVE=6 DRIVE=8 DRIVE=12 (Default) DRIVE=16 DRIVE=24

Design Considerations

Reference Voltage (V_{RFF}) Pins

Low-voltage I/O standards with a differential amplifier input buffer require an input reference voltage (V_{RFF}). Provide the V_{RFF} as an external signal to the device.

The voltage reference signal is "banked" within the device on a half-edge basis such that for all packages there are eight independent V_{RFF} banks internally. See Figure 36, page 39 for a representation of the I/O banks. Within each bank approximately one of every six I/O pins is automatically configured as a V_{RFF} input.

Within each V_{REF} bank, any input buffers that require a V_{RFF} signal must be of the same type. Output buffers of any type and input buffers can be placed without requiring a reference voltage within the same V_{REF} bank.

Output Drive Source Voltage (V_{CCO}) Pins

Many of the low voltage I/O standards supported by Versatile I/Os require a different output drive source voltage (V_{CCO}) . As a result each device can often have to support multiple output drive source voltages.

The V_{CCO} supplies are internally tied together for some packages. The VQ100 and the PQ208 provide one combined $V_{\mbox{\scriptsize CCO}}$ supply. The TQ144 and the CS144 packages provide four independent V_{CCO} supplies. The FG256 and the FG456 provide eight independent V_{CCO} supplies.

Output buffers within a given V_{CCO} bank must share the same output drive source voltage. Input buffers for LVTTL, LVCMOS2, PCI33_3, and PCI 66_3 use the V_{CCO} voltage for Input V_{CCO} voltage.

Transmission Line Effects

The delay of an electrical signal along a wire is dominated by the rise and fall times when the signal travels a short distance. Transmission line delays vary with inductance and capacitance, but a well-designed board can experience delays of approximately 180 ps per inch.

Transmission line effects, or reflections, typically start at 1.5" for fast (1.5 ns) rise and fall times. Poor (or non-existent) termination or changes in the transmission line impedance cause these reflections and can cause additional delay in longer traces. As system speeds continue to increase, the effect of I/O delays can become a limiting factor and therefore transmission line termination becomes increasingly more important.

Termination Techniques

A variety of termination techniques reduce the impact of transmission line effects.

The following lists output termination techniques:

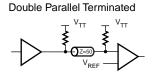
None Series Parallel (Shunt) Series and Parallel (Series-Shunt)

Input termination techniques include the following:

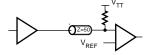
None Parallel (Shunt)

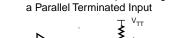
These termination techniques can be applied in any combination. A generic example of each combination of termination methods appears in Figure 41.





Unterminated Output Driving a Parallel Terminated Input

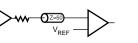




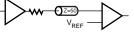
Series Terminated Output Driving

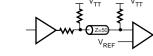
Series-Parallel Terminated Output

Series Terminated Output



Driving a Parallel Terminated Input VTT





DS001 41 032300

Figure 41: Overview of Standard Input and Output **Termination Methods**

Simultaneous Switching Guidelines

Ground bounce can occur with high-speed digital ICs when multiple outputs change states simultaneously, causing undesired transient behavior on an output, or in the internal logic. This problem is also referred to as the Simultaneous Switching Output (SSO) problem.

Ground bounce is primarily due to current changes in the combined inductance of ground pins, bond wires, and

SSTL3 Class I

A sample circuit illustrating a valid termination technique for SSTL3_I appears in Figure 47. DC voltage specifications appear in Table 25 for the SSTL3_I standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

SSTL3 Class I

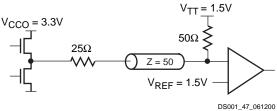


Figure 47: Terminated SSTL3 Class I

| Table 2 | 25: | SSTL3_ | I Voltage | Specifications |
|---------|-----|--------|-----------|----------------|
|---------|-----|--------|-----------|----------------|

| Parameter | Min | Тур | Max |
|---|---------|-----|--------------------|
| V _{CCO} | 3.0 | 3.3 | 3.6 |
| $V_{REF} = 0.45 \times V_{CCO}$ | 1.3 | 1.5 | 1.7 |
| V _{TT} = V _{REF} | 1.3 | 1.5 | 1.7 |
| $V_{IH} \ge V_{REF} + 0.2$ | 1.5 | 1.7 | 3.9 ⁽¹⁾ |
| $V_{IL} \leq V_{REF} - 0.2$ | -0.3(2) | 1.3 | 1.5 |
| $V_{OH} \ge V_{REF} + 0.6$ | 1.9 | - | - |
| $V_{OL} \leq V_{REF} - 0.6$ | - | - | 1.1 |
| I _{OH} at V _{OH} (mA) | -8 | - | - |
| I _{OL} at V _{OL} (mA) | 8 | - | - |

Notes:

1. V_{IH} maximum is V_{CCO} + 0.3.

2. V_{IL} minimum does not conform to the formula.

SSTL3 Class II

A sample circuit illustrating a valid termination technique for SSTL3_II appears in Figure 48. DC voltage specifications appear in Table 26 for the SSTL3_II standard. See "DC Specifications" in Module 3 for the actual FPGA characteristics.

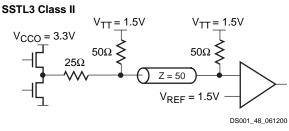


Figure 48: Terminated SSTL3 Class II

Table 26: SSTL3_II Voltage Specifications

| Parameter | Min | Тур | Max |
|--|---------|-----|--------------------|
| V _{CCO} | 3.0 | 3.3 | 3.6 |
| $V_{REF} = 0.45 \times V_{CCO}$ | 1.3 | 1.5 | 1.7 |
| V _{TT} = V _{REF} | 1.3 | 1.5 | 1.7 |
| V _{IH} ≥ V _{REF} + 0.2 | 1.5 | 1.7 | 3.9 ⁽¹⁾ |
| $V_{IL} \leq V_{REF} - 0.2$ | -0.3(2) | 1.3 | 1.5 |
| $V_{OH} \ge V_{REF} + 0.8$ | 2.1 | - | - |
| $V_{OL} \leq V_{REF} - 0.8$ | - | - | 0.9 |
| I _{OH} at V _{OH} (mA) | -16 | - | - |
| I _{OL} at V _{OL} (mA) | 16 | - | - |

Notes:

1. V_{IH} maximum is V_{CCO} + 0.3

2. V_{IL} minimum does not conform to the formula

Recommended Operating Conditions

| Symbol | Description | | Min | Мах | Units |
|--------------------|---|------------|-----------------|----------|-------|
| Т _Ј | Junction temperature ⁽¹⁾ | Commercial | 0 85 -40 100 | | °C |
| | | Industrial | -40 | 100 | °C |
| V _{CCINT} | Supply voltage relative to GND ^(2,5) | Commercial | 2.5 – 5% | 2.5 + 5% | V |
| | | Industrial | 2.5 – 5% | 2.5 + 5% | V |
| V _{CCO} | Supply voltage relative to GND ^(3,5) | Commercial | 1.4 | 3.6 | V |
| | | Industrial | 1.4 | 3.6 | V |
| T _{IN} | Input signal transition time ⁽⁴⁾ | 1 | - | 250 | ns |

Notes:

1. At junction temperatures above those listed as Operating Conditions, all delay parameters increase by 0.35% per °C.

2. Functional operation is guaranteed down to a minimum V_{CCINT} of 2.25V (Nominal $V_{CCINT} - 10\%$). For every 50 mV reduction in V_{CCINT} below 2.375V (nominal $V_{CCINT} - 5\%$), all delay parameters increase by 3%.

3. Minimum and maximum values for V_{CCO} vary according to the I/O standard selected.

4. Input and output measurement threshold is ~50% of V_{CCO}. See "Delay Measurement Methodology," page 60 for specific levels.

5. Supply voltages may be applied in any order desired.

DC Characteristics Over Operating Conditions

| Symbol | Descripti | on | | Min | Тур | Max | Units |
|--------------------|--|--------------------------|--------------------------------|-----|-----|--|-------|
| V _{DRINT} | Data Retention V _{CCINT} voltage (below may be lost) | w which conf | iguration data | 2.0 | - | - | V |
| V _{DRIO} | Data Retention V _{CCO} voltage (below be lost) | which configu | uration data may | 1.2 | - | - | V |
| ICCINTQ | Quiescent V _{CCINT} supply current ⁽¹⁾ | XC2S15 | Commercial | - | 10 | 30 | mA |
| | | | Industrial | - | 10 | 60 | mA |
| | | XC2S30 | Commercial | - | 10 | 30 | mA |
| | | | Industrial | - | 10 | 60 | mA |
| | | XC2S50 | Commercial | - | 12 | - - 30 60 30 | mA |
| | | | Industrial | - | 12 | | mA |
| | | XC2S100 | Commercial | - | 12 | | mA |
| | | | Industrial | - | 12 | 100 | mA |
| | | XC2S150 | Commercial | - | 15 | 50 | mA |
| | | | Industrial | - | 15 | - 30 60 30 60 50 100 50 100 50 100 75 150 2 20 +10 8 0.25 | mA |
| | | XC2S200 | Commercial | - | 15 | 75 | mA |
| | | | Industrial | - | 15 | - 30 60 30 60 50 100 50 100 50 100 75 150 2 20 +10 8 0.25 | mA |
| Iccoq | Quiescent V _{CCO} supply current ⁽¹⁾ | | | - | - | 2 | mA |
| I _{REF} | V _{REF} current per V _{REF} pin | | | - | - | 20 | μA |
| ١L | Input or output leakage current ⁽²⁾ | | | -10 | - | +10 | μA |
| C _{IN} | Input capacitance (sample tested) | VQ, CS, TO packages | VQ, CS, TQ, PQ, FG packages | | - | 8 | pF |
| I _{RPU} | Pad pull-up (when selected) @ V _{IN} = (sample tested) ⁽³⁾ | = 0V, V _{CCO} = | 3.3V | - | - | 0.25 | mA |
| I _{RPD} | Pad pull-down (when selected) @ V | _N = 3.6V (sar | mple tested) ⁽³⁾ | - | - | 0.15 | mA |

Notes:

1. With no output current loads, no active input pull-up resistors, all I/O pins 3-stated and floating.

2. The I/O leakage current specification applies only when the V_{CCINT} and V_{CCO} supply voltages have reached their respective minimum Recommended Operating Conditions.

3. Internal pull-up and pull-down resistors guarantee valid logic levels at unconnected input pins. These pull-up and pull-down resistors do not provide valid logic levels when input pins are connected to other circuits.

DLL Timing Parameters

All devices are 100 percent functionally tested. Because of the difficulty in directly measuring many internal timing parameters, those parameters are derived from benchmark timing patterns. The following guidelines reflect worst-case values across the recommended operating conditions.

| | | | Speed Grade | | | |
|----------------------|------------------------------------|-----|-------------|-----|-----|-------|
| | | | -6 -5 | | | |
| Symbol | Description | Min | Max | Min | Max | Units |
| F _{CLKINHF} | Input clock frequency (CLKDLLHF) | 60 | 200 | 60 | 180 | MHz |
| F _{CLKINLF} | Input clock frequency (CLKDLL) | 25 | 100 | 25 | 90 | MHz |
| T _{DLLPWHF} | Input clock pulse width (CLKDLLHF) | 2.0 | - | 2.4 | - | ns |
| T _{DLLPWLF} | Input clock pulse width (CLKDLL) | 2.5 | - | 3.0 | - | ns |

DLL Clock Tolerance, Jitter, and Phase Information

All DLL output jitter and phase specifications were determined through statistical measurement at the package pins using a clock mirror configuration and matched drivers.

Figure 52, page 63, provides definitions for various parameters in the table below.

| | | | | DLLHF | CLK | DLL | |
|---------------------|--|-------------------------------|-----|-------|-----|------|-------|
| Symbol | Description | F _{CLKIN} | Min | Max | Min | Max | Units |
| T _{IPTOL} | Input clock period tolerance | | - | 1.0 | - | 1.0 | ns |
| T _{IJITCC} | Input clock jitter tolerance (cycle-to-cycle) | | - | ±150 | - | ±300 | ps |
| T _{LOCK} | Time required for DLL to acquire lock | > 60 MHz | - | 20 | - | 20 | μs |
| | | 50-60 MHz | - | - | - | 25 | μs |
| | | 40-50 MHz | - | - | - | 50 | μs |
| | | 30-40 MHz | - | - | - | 90 | μs |
| | | 25-30 MHz | - | - | - | 120 | μs |
| T _{OJITCC} | Output jitter (cycle-to-cycle) for any DLL clock c | output ⁽¹⁾ | - | ±60 | - | ±60 | ps |
| T _{PHIO} | Phase offset between CLKIN and CLKO ⁽²⁾ | | - | ±100 | - | ±100 | ps |
| T _{PHOO} | Phase offset between clock outputs on the DLL | (3) | - | ±140 | - | ±140 | ps |
| T _{PHIOM} | Maximum phase difference between CLKIN and | d CLKO ⁽⁴⁾ | - | ±160 | - | ±160 | ps |
| T _{PHOOM} | Maximum phase difference between clock outp | uts on the DLL ⁽⁵⁾ | - | ±200 | - | ±200 | ps |

Notes:

1. **Output Jitter** is cycle-to-cycle jitter measured on the DLL output clock, *excluding* input clock jitter.

2. Phase Offset between CLKIN and CLKO is the worst-case fixed time difference between rising edges of CLKIN and CLKO, *excluding* output jitter and input clock jitter.

3. Phase Offset between Clock Outputs on the DLL is the worst-case fixed time difference between rising edges of any two DLL outputs, *excluding* Output Jitter and input clock jitter.

4. Maximum Phase Difference between CLKIN an CLKO is the sum of Output Jitter and Phase Offset between CLKIN and CLKO, or the greatest difference between CLKIN and CLKO rising edges due to DLL alone (*excluding* input clock jitter).

5. **Maximum Phase Difference between Clock Outputs on the DLL** is the sum of Output JItter and Phase Offset between any DLL clock outputs, or the greatest difference between any two DLL output rising edges due to DLL alone (*excluding* input clock jitter).

Pinout Tables

The following device-specific pinout tables include all packages available for each Spartan[®]-II device. They follow the pad locations around the die, and include Boundary Scan register locations.

XC2S15 Device Pinouts

| XC2S15 Pad Name | | | | | Bndry |
|--------------------------|------|-------|-------|-------|-------|
| Function | Bank | VQ100 | TQ144 | CS144 | Scan |
| GND | - | P1 | P143 | A1 | - |
| TMS | - | P2 | P142 | B1 | - |
| I/O | 7 | P3 | P141 | C2 | 77 |
| I/O | 7 | - | P140 | C1 | 80 |
| I/O, V _{REF} | 7 | P4 | P139 | D4 | 83 |
| I/O | 7 | P5 | P137 | D2 | 86 |
| I/O | 7 | P6 | P136 | D1 | 89 |
| GND | - | - | P135 | E4 | - |
| I/O | 7 | P7 | P134 | E3 | 92 |
| I/O | 7 | - | P133 | E2 | 95 |
| I/O, V _{REF} | 7 | P8 | P132 | E1 | 98 |
| I/O | 7 | P9 | P131 | F4 | 101 |
| I/O | 7 | - | P130 | F3 | 104 |
| I/O, IRDY ⁽¹⁾ | 7 | P10 | P129 | F2 | 107 |
| GND | - | P11 | P128 | F1 | - |
| V _{CCO} | 7 | P12 | P127 | G2 | - |
| V _{CCO} | 6 | P12 | P127 | G2 | - |
| I/O, TRDY ⁽¹⁾ | 6 | P13 | P126 | G1 | 110 |
| V _{CCINT} | - | P14 | P125 | G3 | - |
| I/O | 6 | - | P124 | G4 | 113 |
| I/O | 6 | P15 | P123 | H1 | 116 |
| I/O, V _{REF} | 6 | P16 | P122 | H2 | 119 |
| I/O | 6 | - | P121 | H3 | 122 |
| I/O | 6 | P17 | P120 | H4 | 125 |
| GND | - | - | P119 | J1 | - |
| I/O | 6 | P18 | P118 | J2 | 128 |
| I/O | 6 | P19 | P117 | J3 | 131 |
| I/O, V _{REF} | 6 | P20 | P115 | K1 | 134 |
| I/O | 6 | - | P114 | K2 | 137 |
| I/O | 6 | P21 | P113 | K3 | 140 |
| I/O | 6 | P22 | P112 | L1 | 143 |
| M1 | - | P23 | P111 | L2 | 146 |
| GND | - | P24 | P110 | L3 | - |
| M0 | - | P25 | P109 | M1 | 147 |
| V _{CCO} | 6 | P26 | P108 | M2 | - |
| V _{CCO} | 5 | P26 | P107 | N1 | - |

XC2S15 Device Pinouts (Continued)

| XC2S15 Pad Name | | | | | Bndry |
|-----------------------|------|-------|-------|-------|-------|
| Function | Bank | VQ100 | TQ144 | CS144 | Scan |
| M2 | - | P27 | P106 | N2 | 148 |
| I/O | 5 | - | P103 | K4 | 155 |
| I/O, V _{REF} | 5 | P30 | P102 | L4 | 158 |
| I/O | 5 | P31 | P100 | N4 | 161 |
| I/O | 5 | P32 | P99 | K5 | 164 |
| GND | - | - | P98 | L5 | - |
| V _{CCINT} | - | P33 | P97 | M5 | - |
| I/O | 5 | - | P96 | N5 | 167 |
| I/O | 5 | - | P95 | K6 | 170 |
| I/O, V _{REF} | 5 | P34 | P94 | L6 | 173 |
| I/O | 5 | - | P93 | M6 | 176 |
| V _{CCINT} | - | P35 | P92 | N6 | - |
| I, GCK1 | 5 | P36 | P91 | M7 | 185 |
| V _{CCO} | 5 | P37 | P90 | N7 | - |
| V _{CCO} | 4 | P37 | P90 | N7 | - |
| GND | - | P38 | P89 | L7 | - |
| I, GCK0 | 4 | P39 | P88 | K7 | 186 |
| I/O | 4 | P40 | P87 | N8 | 190 |
| I/O | 4 | - | P86 | M8 | 193 |
| I/O, V _{REF} | 4 | P41 | P85 | L8 | 196 |
| I/O | 4 | - | P84 | K8 | 199 |
| I/O | 4 | - | P83 | N9 | 202 |
| V _{CCINT} | - | P42 | P82 | M9 | - |
| GND | - | - | P81 | L9 | - |
| I/O | 4 | P43 | P80 | K9 | 205 |
| I/O | 4 | P44 | P79 | N10 | 208 |
| I/O, V _{REF} | 4 | P45 | P77 | L10 | 211 |
| I/O | 4 | - | P76 | N11 | 214 |
| I/O | 4 | P46 | P75 | M11 | 217 |
| I/O | 4 | P47 | P74 | L11 | 220 |
| GND | - | P48 | P73 | N12 | - |
| DONE | 3 | P49 | P72 | M12 | 223 |
| V _{cco} | 4 | P50 | P71 | N13 | - |
| V _{CCO} | 3 | P50 | P70 | M13 | - |
| PROGRAM | - | P51 | P69 | L12 | 226 |
| I/O (INIT) | 3 | P52 | P68 | L13 | 227 |
| I/O (D7) | 3 | P53 | P67 | K10 | 230 |
| I/O | 3 | - | P66 | K11 | 233 |
| I/O, V _{REF} | 3 | P54 | P65 | K12 | 236 |
| I/O | 3 | P55 | P63 | J10 | 239 |
| I/O (D6) | 3 | P56 | P62 | J11 | 233 |
| "O (DO) | 5 | 1.00 | 102 | 011 | 272 |

XC2S30 Device Pinouts (Continued)

| XC2S30 Pad | Name | | | | | Bndry |
|--------------------------|------|-------|-------|-------|-------|-------|
| Function | Bank | VQ100 | TQ144 | CS144 | PQ208 | Scan |
| I/O | 4 | - | - | - | P87 | 295 |
| I/O | 4 | - | - | - | P88 | 298 |
| I/O | 4 | - | P84 | K8 | P89 | 301 |
| I/O | 4 | - | P83 | N9 | P90 | 304 |
| V _{CCINT} | - | P42 | P82 | M9 | P91 | - |
| V _{CCO} | 4 | - | - | - | P92 | - |
| GND | - | - | P81 | L9 | P93 | - |
| I/O | 4 | P43 | P80 | K9 | P94 | 307 |
| I/O | 4 | P44 | P79 | N10 | P95 | 310 |
| I/O | 4 | - | P78 | M10 | P96 | 313 |
| I/O, V _{REF} | 4 | P45 | P77 | L10 | P98 | 316 |
| I/O | 4 | - | - | - | P99 | 319 |
| I/O | 4 | - | P76 | N11 | P100 | 322 |
| I/O | 4 | P46 | P75 | M11 | P101 | 325 |
| I/O | 4 | P47 | P74 | L11 | P102 | 328 |
| GND | - | P48 | P73 | N12 | P103 | - |
| DONE | 3 | P49 | P72 | M12 | P104 | 331 |
| V _{CCO} | 4 | P50 | P71 | N13 | P105 | - |
| V _{CCO} | 3 | P50 | P70 | M13 | P105 | - |
| PROGRAM | - | P51 | P69 | L12 | P106 | 334 |
| I/O (INIT) | 3 | P52 | P68 | L13 | P107 | 335 |
| I/O (D7) | 3 | P53 | P67 | K10 | P108 | 338 |
| I/O | 3 | - | P66 | K11 | P109 | 341 |
| I/O | 3 | - | - | - | P110 | 344 |
| I/O, V _{REF} | 3 | P54 | P65 | K12 | P111 | 347 |
| I/O | 3 | - | P64 | K13 | P113 | 350 |
| I/O | 3 | P55 | P63 | J10 | P114 | 353 |
| I/O (D6) | 3 | P56 | P62 | J11 | P115 | 356 |
| GND | - | - | P61 | J12 | P116 | - |
| V _{CCO} | 3 | - | - | - | P117 | - |
| I/O (D5) | 3 | P57 | P60 | J13 | P119 | 359 |
| I/O | 3 | P58 | P59 | H10 | P120 | 362 |
| I/O | 3 | - | - | - | P121 | 365 |
| I/O | 3 | - | - | - | P122 | 368 |
| I/O | 3 | - | - | - | P123 | 371 |
| GND | - | - | - | - | P124 | - |
| I/O, V _{REF} | 3 | P59 | P58 | H11 | P125 | 374 |
| I/O (D4) | 3 | P60 | P57 | H12 | P126 | 377 |
| 1/0 | 3 | - | P56 | H13 | P127 | 380 |
| V _{CCINT} | - | P61 | P55 | G12 | P128 | - |
| I/O, TRDY ⁽¹⁾ | 3 | P62 | P54 | G13 | P129 | 386 |

XC2S30 Device Pinouts (Continued)

| XC2S30 Pad Name | | | | | | D |
|--------------------------|------|-------|-------|-------|-------|---------------|
| Function | Bank | VQ100 | TQ144 | CS144 | PQ208 | Bndry Scan |
| V _{CCO} | 3 | P63 | P53 | G11 | P130 | - |
| V _{CCO} | 2 | P63 | P53 | G11 | P130 | - |
| GND | - | P64 | P52 | G10 | P131 | - |
| I/O, IRDY ⁽¹⁾ | 2 | P65 | P51 | F13 | P132 | 389 |
| I/O | 2 | - | - | - | P133 | 392 |
| I/O | 2 | - | P50 | F12 | P134 | 395 |
| I/O (D3) | 2 | P66 | P49 | F11 | P135 | 398 |
| I/O, V _{REF} | 2 | P67 | P48 | F10 | P136 | 401 |
| GND | - | - | - | - | P137 | - |
| I/O | 2 | - | - | - | P138 | 404 |
| I/O | 2 | - | - | - | P139 | 407 |
| I/O | 2 | - | - | - | P140 | 410 |
| I/O | 2 | P68 | P47 | E13 | P141 | 413 |
| I/O (D2) | 2 | P69 | P46 | E12 | P142 | 416 |
| V _{CCO} | 2 | - | - | - | P144 | - |
| GND | - | - | P45 | E11 | P145 | - |
| I/O (D1) | 2 | P70 | P44 | E10 | P146 | 419 |
| I/O | 2 | P71 | P43 | D13 | P147 | 422 |
| I/O | 2 | - | P42 | D12 | P148 | 425 |
| I/O, V _{REF} | 2 | P72 | P41 | D11 | P150 | 428 |
| I/O | 2 | - | - | - | P151 | 431 |
| I/O | 2 | - | P40 | C13 | P152 | 434 |
| I/O (DIN, D0) | 2 | P73 | P39 | C12 | P153 | 437 |
| I/O (DOUT, BUSY) | 2 | P74 | P38 | C11 | P154 | 440 |
| CCLK | 2 | P75 | P37 | B13 | P155 | 443 |
| V _{CCO} | 2 | P76 | P36 | B12 | P156 | - |
| V _{CCO} | 1 | P76 | P35 | A13 | P156 | - |
| TDO | 2 | P77 | P34 | A12 | P157 | - |
| GND | - | P78 | P33 | B11 | P158 | - |
| TDI | - | P79 | P32 | A11 | P159 | - |
| I/O (CS) | 1 | P80 | P31 | D10 | P160 | 0 |
| I/O (WRITE) | 1 | P81 | P30 | C10 | P161 | 3 |
| I/O | 1 | - | P29 | B10 | P162 | 6 |
| I/O | 1 | - | - | - | P163 | 9 |
| I/O, V _{REF} | 1 | P82 | P28 | A10 | P164 | 12 |
| I/O | 1 | - | - | - | P166 | 15 |
| I/O | 1 | P83 | P27 | D9 | P167 | 18 |
| I/O | 1 | P84 | P26 | C9 | P168 | 21 |
| GND | - | - | P25 | B9 | P169 | - |
| V _{CCO} | 1 | - | - | - | P170 | - |

XC2S50 Device Pinouts (Continued)

| XC2S50 Pad | Name | | | | Bndry |
|--------------------------|------|-------|-------|-----------------------------|-------|
| Function | Bank | TQ144 | PQ208 | FG256 | Scan |
| I/O | 3 | - | - | J14 | 503 |
| I/O | 3 | P56 | P127 | K15 | 506 |
| V _{CCINT} | - | P55 | P128 | V _{CCINT} * | - |
| I/O, TRDY ⁽¹⁾ | 3 | P54 | P129 | J15 | 512 |
| V _{CCO} | 3 | P53 | P130 | V _{CCO} Bank 3* | - |
| V _{CCO} | 2 | P53 | P130 | V _{CCO} Bank 2* | - |
| GND | - | P52 | P131 | GND* | - |
| I/O, IRDY ⁽¹⁾ | 2 | P51 | P132 | H16 | 515 |
| I/O | 2 | - | P133 | H14 | 518 |
| I/O | 2 | P50 | P134 | H15 | 521 |
| I/O | 2 | - | - | J13 | 524 |
| I/O (D3) | 2 | P49 | P135 | G16 | 527 |
| I/O, V _{REF} | 2 | P48 | P136 | H13 | 530 |
| GND | - | - | P137 | GND* | - |
| I/O | 2 | - | P138 | G14 | 533 |
| I/O | 2 | - | P139 | G15 | 536 |
| I/O | 2 | - | P140 | G12 | 539 |
| I/O | 2 | - | - | F16 | 542 |
| I/O | 2 | P47 | P141 | G13 | 545 |
| I/O (D2) | 2 | P46 | P142 | F15 | 548 |
| V _{CCINT} | - | - | P143 | V _{CCINT} * | - |
| V _{CCO} | 2 | - | P144 | V _{CCO} Bank 2* | - |
| GND | - | P45 | P145 | GND* | - |
| I/O (D1) | 2 | P44 | P146 | E16 | 551 |
| I/O | 2 | P43 | P147 | F14 | 554 |
| I/O | 2 | P42 | P148 | D16 | 557 |
| I/O | 2 | - | - | F12 | 560 |
| I/O | 2 | - | P149 | E15 | 563 |
| I/O, V _{REF} | 2 | P41 | P150 | F13 | 566 |
| GND | - | - | - | GND* | - |
| I/O | 2 | - | P151 | E14 | 569 |
| I/O | 2 | - | - | C16 | 572 |
| I/O | 2 | P40 | P152 | E13 | 575 |
| I/O | 2 | - | - | B16 | 578 |
| I/O (DIN, D0) | 2 | P39 | P153 | D14 | 581 |
| I/O (DOUT, BUSY) | 2 | P38 | P154 | C15 | 584 |
| CCLK | 2 | P37 | P155 | D15 | 587 |
| V _{CCO} | 2 | P36 | P156 | V _{CCO} Bank 2* | - |

XC2S50 Device Pinouts (Continued)

| XC2S50 Pad Name | | | | | Bndry |
|-----------------------|------|-------|-------|-----------------------------|-------|
| Function | Bank | TQ144 | PQ208 | FG256 | Scan |
| V _{CCO} | 1 | P35 | P156 | V _{CCO} Bank 1* | - |
| TDO | 2 | P34 | P157 | B14 | - |
| GND | - | P33 | P158 | GND* | - |
| TDI | - | P32 | P159 | A15 | - |
| I/O (<u>CS</u>) | 1 | P31 | P160 | B13 | 0 |
| I/O (WRITE) | 1 | P30 | P161 | C13 | 3 |
| I/O | 1 | - | - | C12 | 6 |
| I/O | 1 | P29 | P162 | A14 | 9 |
| I/O | 1 | - | - | D12 | 12 |
| I/O | 1 | - | P163 | B12 | 15 |
| GND | - | - | - | GND* | - |
| I/O, V _{REF} | 1 | P28 | P164 | C11 | 18 |
| I/O | 1 | - | P165 | A13 | 21 |
| I/O | 1 | - | - | D11 | 24 |
| I/O | 1 | - | P166 | A12 | 27 |
| I/O | 1 | P27 | P167 | E11 | 30 |
| I/O | 1 | P26 | P168 | B11 | 33 |
| GND | - | P25 | P169 | GND* | - |
| V _{CCO} | 1 | - | P170 | V _{CCO} Bank 1* | - |
| V _{CCINT} | - | P24 | P171 | V _{CCINT} * | - |
| I/O | 1 | P23 | P172 | A11 | 36 |
| I/O | 1 | P22 | P173 | C10 | 39 |
| I/O | 1 | - | P174 | B10 | 45 |
| I/O | 1 | - | P175 | D10 | 48 |
| I/O | 1 | - | P176 | A10 | 51 |
| GND | - | - | P177 | GND* | - |
| I/O, V _{REF} | 1 | P21 | P178 | B9 | 54 |
| I/O | 1 | - | P179 | E10 | 57 |
| I/O | 1 | - | - | A9 | 60 |
| I/O | 1 | P20 | P180 | D9 | 63 |
| I/O | 1 | P19 | P181 | A8 | 66 |
| I, GCK2 | 1 | P18 | P182 | C9 | 72 |
| GND | - | P17 | P183 | GND* | - |
| V _{cco} | 1 | P16 | P184 | V _{CCO} Bank 1* | - |
| V _{CCO} | 0 | P16 | P184 | V _{CCO} Bank 0* | - |
| I, GCK3 | 0 | P15 | P185 | B8 | 73 |
| V _{CCINT} | - | P14 | P186 | V _{CCINT} * | - |
| I/O | 0 | P13 | P187 | A7 | 80 |

XC2S150 Device Pinouts (Continued)

| XC2S150 Pad | Name | | | | Bndry |
|--------------------------|------|-------|-----------------------------|-----------------------------|-------|
| Function | Bank | PQ208 | FG256 | FG456 | Scan |
| I/O, IRDY ⁽¹⁾ | 2 | P132 | H16 | L20 | 767 |
| I/O | 2 | P133 | H14 | L17 | 770 |
| I/O | 2 | - | - | L18 | 773 |
| I/O | 2 | P134 | H15 | L21 | 776 |
| I/O | 2 | - | J13 | L22 | 779 |
| I/O (D3) | 2 | P135 | G16 | K20 | 782 |
| I/O, V _{REF} | 2 | P136 | H13 | K21 | 785 |
| V _{CCO} | 2 | - | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| GND | - | P137 | GND* | GND* | - |
| I/O | 2 | P138 | G14 | K22 | 788 |
| I/O | 2 | P139 | G15 | J21 | 791 |
| I/O | 2 | - | - | J20 | 797 |
| I/O | 2 | P140 | G12 | J18 | 800 |
| I/O | 2 | - | F16 | J22 | 803 |
| I/O | 2 | - | - | J19 | 806 |
| I/O | 2 | P141 | G13 | H19 | 812 |
| I/O (D2) | 2 | P142 | F15 | H20 | 815 |
| V _{CCINT} | - | P143 | V _{CCINT} * | V _{CCINT} * | - |
| V _{CCO} | 2 | P144 | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| GND | - | P145 | GND* | GND* | - |
| I/O (D1) | 2 | P146 | E16 | H22 | 818 |
| I/O, V _{REF} | 2 | P147 | F14 | H18 | 821 |
| I/O | 2 | - | - | G21 | 824 |
| I/O | 2 | P148 | D16 | G18 | 827 |
| I/O | 2 | - | F12 | G20 | 830 |
| I/O | 2 | - | - | G19 | 833 |
| I/O | 2 | - | - | F22 | 836 |
| I/O | 2 | P149 | E15 | F19 | 839 |
| I/O, V _{REF} | 2 | P150 | F13 | F21 | 842 |
| V _{CCO} | 2 | - | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| GND | - | - | GND* | GND* | - |
| I/O | 2 | P151 | E14 | F20 | 845 |
| I/O | 2 | - | C16 | F18 | 848 |
| I/O | 2 | - | - | E22 | 851 |
| I/O | 2 | - | - | E21 | 854 |
| I/O | 2 | P152 | E13 | D22 | 857 |
| GND | - | - | GND* | GND* | - |
| I/O | 2 | - | B16 | E20 | 860 |
| I/O | 2 | - | - | D21 | 863 |

XC2S150 Device Pinouts (Continued)

| XC2S150 Pad Name | | | • | | Bndry |
|-----------------------|------|-------|-----------------------------|-----------------------------|-------|
| Function | Bank | PQ208 | FG256 | FG456 | Scan |
| I/O | 2 | - | - | C22 | 866 |
| I/O (DIN, D0) | 2 | P153 | D14 | D20 | 869 |
| I/O (DOUT, BUSY) | 2 | P154 | C15 | C21 | 872 |
| CCLK | 2 | P155 | D15 | B22 | 875 |
| V _{CCO} | 2 | P156 | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| V _{CCO} | 1 | P156 | V _{CCO} Bank 1* | V _{CCO} Bank 1* | - |
| TDO | 2 | P157 | B14 | A21 | - |
| GND | - | P158 | GND* | GND* | - |
| TDI | - | P159 | A15 | B20 | - |
| I/O (CS) | 1 | P160 | B13 | C19 | 0 |
| I/O (WRITE) | 1 | P161 | C13 | A20 | 3 |
| I/O | 1 | - | - | B19 | 6 |
| I/O | 1 | - | - | C18 | 9 |
| I/O | 1 | - | C12 | D17 | 12 |
| GND | - | - | GND* | GND* | - |
| I/O | 1 | P162 | A14 | A19 | 15 |
| I/O | 1 | - | - | B18 | 18 |
| I/O | 1 | - | - | E16 | 21 |
| I/O | 1 | - | D12 | C17 | 24 |
| I/O | 1 | P163 | B12 | D16 | 27 |
| GND | - | - | GND* | GND* | - |
| V _{CCO} | 1 | - | V _{CCO} Bank 1* | V _{CCO} Bank 1* | - |
| I/O, V _{REF} | 1 | P164 | C11 | A18 | 30 |
| I/O | 1 | P165 | A13 | B17 | 33 |
| I/O | 1 | - | - | E15 | 36 |
| I/O | 1 | - | - | A17 | 39 |
| I/O | 1 | - | D11 | D15 | 42 |
| I/O | 1 | P166 | A12 | C16 | 45 |
| I/O | 1 | - | - | D14 | 48 |
| I/O, V _{REF} | 1 | P167 | E11 | E14 | 51 |
| I/O | 1 | P168 | B11 | A16 | 54 |
| GND | - | P169 | GND* | GND* | - |
| V _{CCO} | 1 | P170 | V _{CCO} Bank 1* | V _{CCO} Bank 1* | - |
| V _{CCINT} | - | P171 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 1 | P172 | A11 | C15 | 57 |
| I/O | 1 | P173 | C10 | B15 | 60 |
| I/O | 1 | - | - | A15 | 66 |
| I/O | 1 | - | - | F12 | 69 |

XC2S150 Device Pinouts (Continued)

| XC2S150 Pa | d Name | | | | Bndry |
|-----------------------|--------|-------|-----------------------------|-----------------------------|-------|
| Function | Bank | PQ208 | FG256 | FG456 | Scan |
| I/O | 1 | P174 | B10 | C14 | 72 |
| I/O | 1 | - | - | B14 | 75 |
| I/O | 1 | P175 | D10 | D13 | 81 |
| I/O | 1 | P176 | A10 | C13 | 84 |
| GND | - | P177 | GND* | GND* | - |
| V _{cco} | 1 | - | V _{CCO} Bank 1* | V _{CCO} Bank 1* | - |
| I/O, V _{REF} | 1 | P178 | B9 | B13 | 87 |
| I/O | 1 | P179 | E10 | E12 | 90 |
| I/O | 1 | - | A9 | B12 | 93 |
| I/O | 1 | P180 | D9 | D12 | 96 |
| I/O | 1 | - | - | C12 | 99 |
| I/O | 1 | P181 | A8 | D11 | 102 |
| I, GCK2 | 1 | P182 | C9 | A11 | 108 |
| GND | - | P183 | GND* | GND* | - |
| V _{CCO} | 1 | P184 | V _{CCO} Bank 1* | V _{CCO} Bank 1* | - |
| V _{CCO} | 0 | P184 | V _{CCO} Bank 0* | V _{CCO} Bank 0* | - |
| I, GCK3 | 0 | P185 | B8 | C11 | 109 |
| V _{CCINT} | - | P186 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 0 | - | - | E11 | 116 |
| I/O | 0 | P187 | A7 | A10 | 119 |
| I/O | 0 | - | D8 | B10 | 122 |
| I/O | 0 | P188 | A6 | C10 | 125 |
| I/O, V _{REF} | 0 | P189 | B7 | A9 | 128 |
| V _{CCO} | 0 | - | V _{CCO} Bank 0* | V _{CCO} Bank 0* | - |
| GND | - | P190 | GND* | GND* | - |
| I/O | 0 | P191 | C8 | B9 | 131 |
| I/O | 0 | P192 | D7 | E10 | 134 |
| I/O | 0 | - | - | D10 | 140 |
| I/O | 0 | P193 | E7 | A8 | 143 |
| I/O | 0 | - | - | D9 | 146 |
| I/O | 0 | - | - | B8 | 149 |
| I/O | 0 | P194 | C7 | E9 | 155 |
| I/O | 0 | P195 | B6 | A7 | 158 |

XC2S150 Device Pinouts (Continued)

| XC2S150 Pac | d Name | | | | Bndry |
|-----------------------|--------|-------|-----------------------------|-----------------------------|-------|
| Function | Bank | PQ208 | FG256 | FG456 | Scan |
| V _{CCINT} | - | P196 | V _{CCINT} * | V _{CCINT} * | - |
| V _{CCO} | 0 | P197 | V _{CCO} Bank 0* | V _{CCO} Bank 0* | - |
| GND | - | P198 | GND* | GND* | - |
| I/O | 0 | P199 | A5 | B7 | 161 |
| I/O, V _{REF} | 0 | P200 | C6 | E8 | 164 |
| I/O | 0 | - | - | D8 | 167 |
| I/O | 0 | P201 | B5 | C7 | 170 |
| I/O | 0 | - | D6 | D7 | 173 |
| I/O | 0 | - | - | B6 | 176 |
| I/O | 0 | - | - | A5 | 179 |
| I/O | 0 | P202 | A4 | D6 | 182 |
| I/O, V _{REF} | 0 | P203 | B4 | C6 | 185 |
| V _{CCO} | 0 | - | V _{CCO} Bank 0* | V _{CCO} Bank 0* | - |
| GND | - | - | GND* | GND* | - |
| I/O | 0 | P204 | E6 | B5 | 188 |
| I/O | 0 | - | D5 | E7 | 191 |
| I/O | 0 | - | - | A4 | 194 |
| I/O | 0 | - | - | E6 | 197 |
| I/O | 0 | P205 | A3 | B4 | 200 |
| GND | - | - | GND* | GND* | - |
| I/O | 0 | - | C5 | A3 | 203 |
| I/O | 0 | - | - | B3 | 206 |
| I/O | 0 | - | - | D5 | 209 |
| I/O | 0 | P206 | B3 | C5 | 212 |
| TCK | - | P207 | C4 | C4 | - |
| V _{cco} | 0 | P208 | V _{CCO} Bank 0* | V _{CCO} Bank 0* | - |
| V _{CCO} | 7 | P208 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |

04/18/01 Notes:

- 1. IRDY and TRDY can only be accessed when using Xilinx PCI cores.
- Pads labelled GND*, V_{CCINT}*, V_{CCO} Bank 0*, V_{CCO} Bank 1*, V_{CCO} Bank 2*, V_{CCO} Bank 3*, V_{CCO} Bank 4*, V_{CCO} Bank 5*, V_{CCO} Bank 6*, V_{CCO} Bank 7* are internally bonded to independent ground or power planes within the package.
- 3. See "VCCO Banks" for details on V_{CCO} banking.

XC2S200 Device Pinouts

| XC2S200 Pad Name | | | | | |
|-----------------------|------|-------|-----------------------------|-----------------------------|---------------|
| Function | Bank | PQ208 | FG256 | FG456 | Bndry Scan |
| GND | - | P1 | GND* | GND* | - |
| TMS | - | P2 | D3 | D3 | - |
| I/O | 7 | P3 | C2 | B1 | 257 |
| I/O | 7 | - | - | E4 | 263 |
| I/O | 7 | - | - | C1 | 266 |
| I/O | 7 | - | A2 | F5 | 269 |
| GND | - | - | GND* | GND* | - |
| I/O, V _{REF} | 7 | P4 | B1 | D2 | 272 |
| I/O | 7 | - | - | E3 | 275 |
| I/O | 7 | - | - | F4 | 281 |
| GND | - | - | GND* | GND* | - |
| I/O | 7 | - | E3 | G5 | 284 |
| I/O | 7 | P5 | D2 | F3 | 287 |
| GND | - | - | GND* | GND* | - |
| V _{CCO} | 7 | - | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| I/O, V _{REF} | 7 | P6 | C1 | E2 | 290 |
| I/O | 7 | P7 | F3 | E1 | 293 |
| I/O | 7 | - | - | G4 | 296 |
| I/O | 7 | - | - | G3 | 299 |
| I/O | 7 | - | E2 | H5 | 302 |
| GND | - | - | GND* | GND* | - |
| I/O | 7 | P8 | E4 | F2 | 305 |
| I/O | 7 | - | - | F1 | 308 |
| I/O, V _{REF} | 7 | P9 | D1 | H4 | 314 |
| I/O | 7 | P10 | E1 | G1 | 317 |
| GND | - | P11 | GND* | GND* | - |
| V _{CCO} | 7 | P12 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| V _{CCINT} | - | P13 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 7 | P14 | F2 | H3 | 320 |
| I/O | 7 | P15 | G3 | H2 | 323 |
| I/O | 7 | - | - | J4 | 326 |
| I/O | 7 | - | - | H1 | 329 |
| I/O | 7 | - | F1 | J5 | 332 |
| GND | - | - | GND* | GND* | - |
| I/O | 7 | P16 | F4 | J2 | 335 |
| I/O | 7 | - | - | J3 | 338 |
| I/O | 7 | - | - | J1 | 341 |
| I/O | 7 | P17 | F5 | K5 | 344 |
| I/O | 7 | P18 | G2 | K1 | 347 |
| GND | - | P19 | GND* | GND* | - |

XC2S200 Device Pinouts (Continued)

| XC2S200 Pad Name | | | - | | Bndry |
|--------------------------|------|-------|-----------------------------|-----------------------------|-------|
| Function | Bank | PQ208 | FG256 | FG456 | Scan |
| V _{CCO} | 7 | - | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| I/O, V _{REF} | 7 | P20 | H3 | K3 | 350 |
| I/O | 7 | P21 | G4 | K4 | 353 |
| I/O | 7 | - | - | K2 | 359 |
| I/O | 7 | - | H2 | L6 | 362 |
| I/O | 7 | P22 | G5 | L1 | 365 |
| I/O | 7 | - | - | L5 | 368 |
| I/O | 7 | P23 | H4 | L4 | 374 |
| I/O, IRDY ⁽¹⁾ | 7 | P24 | G1 | L3 | 377 |
| GND | - | P25 | GND* | GND* | - |
| V _{CCO} | 7 | P26 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| V _{CCO} | 6 | P26 | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| I/O, TRDY ⁽¹⁾ | 6 | P27 | J2 | M1 | 380 |
| V _{CCINT} | - | P28 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 6 | - | - | M6 | 389 |
| I/O | 6 | P29 | H1 | M3 | 392 |
| I/O | 6 | - | J4 | M4 | 395 |
| I/O | 6 | - | - | N1 | 398 |
| I/O | 6 | P30 | J1 | M5 | 404 |
| I/O, V _{REF} | 6 | P31 | J3 | N2 | 407 |
| V _{CCO} | 6 | - | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| GND | - | P32 | GND* | GND* | - |
| I/O | 6 | P33 | K5 | N3 | 410 |
| I/O | 6 | P34 | K2 | N4 | 413 |
| I/O | 6 | - | - | P1 | 416 |
| I/O | 6 | - | - | N5 | 419 |
| I/O | 6 | P35 | K1 | P2 | 422 |
| GND | - | - | GND* | GND* | - |
| I/O | 6 | - | K3 | P4 | 425 |
| I/O | 6 | - | - | R1 | 428 |
| I/O | 6 | - | - | P5 | 431 |
| I/O | 6 | P36 | L1 | P3 | 434 |
| I/O | 6 | P37 | L2 | R2 | 437 |
| V _{CCINT} | - | P38 | V _{CCINT} * | V _{CCINT} * | - |
| V _{CCO} | 6 | P39 | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| GND | - | P40 | GND* | GND* | - |
| I/O | 6 | P41 | K4 | T1 | 440 |
| I/O, V _{REF} | 6 | P42 | M1 | R4 | 443 |

XC2S200 Device Pinouts (Continued)

| XC2S200 Pac | d Name | | | | Bndry |
|--------------------------|--------|-------|-----------------------------|-----------------------------|-------|
| Function | Bank | PQ208 | FG256 | FG456 | Scan |
| V _{CCO} | 3 | P117 | V _{CCO} Bank 3* | V _{CCO} Bank 3* | - |
| V _{CCINT} | - | P118 | V _{CCINT} * | V _{CCINT} * | - |
| I/O (D5) | 3 | P119 | M16 | R21 | 833 |
| I/O | 3 | P120 | K14 | P18 | 836 |
| I/O | 3 | - | - | R22 | 839 |
| I/O | 3 | - | - | P19 | 842 |
| I/O | 3 | - | L16 | P20 | 845 |
| GND | - | - | GND* | GND* | - |
| I/O | 3 | P121 | K13 | P21 | 848 |
| I/O | 3 | - | - | N19 | 851 |
| I/O | 3 | - | - | P22 | 854 |
| I/O | 3 | P122 | L15 | N18 | 857 |
| I/O | 3 | P123 | K12 | N20 | 860 |
| GND | - | P124 | GND* | GND* | - |
| V _{CCO} | 3 | - | V _{CCO} Bank 3* | V _{CCO} Bank 3* | - |
| I/O, V _{REF} | 3 | P125 | K16 | N21 | 863 |
| I/O (D4) | 3 | P126 | J16 | N22 | 866 |
| I/O | 3 | - | - | M17 | 872 |
| I/O | 3 | - | J14 | M19 | 875 |
| I/O | 3 | P127 | K15 | M20 | 878 |
| I/O | 3 | - | - | M18 | 881 |
| V _{CCINT} | - | P128 | V _{CCINT} * | V _{CCINT} * | - |
| I/O, TRDY ⁽¹⁾ | 3 | P129 | J15 | M22 | 890 |
| V _{CCO} | 3 | P130 | V _{CCO} Bank 3* | V _{CCO} Bank 3* | - |
| V _{CCO} | 2 | P130 | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| GND | - | P131 | GND* | GND* | - |
| I/O, IRDY ⁽¹⁾ | 2 | P132 | H16 | L20 | 893 |
| I/O | 2 | P133 | H14 | L17 | 896 |
| I/O | 2 | - | - | L18 | 902 |
| I/O | 2 | P134 | H15 | L21 | 905 |
| I/O | 2 | - | J13 | L22 | 908 |
| I/O | 2 | - | - | K19 | 911 |
| I/O (D3) | 2 | P135 | G16 | K20 | 917 |
| I/O, V _{REF} | 2 | P136 | H13 | K21 | 920 |
| V _{CCO} | 2 | - | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| GND | - | P137 | GND* | GND* | - |
| I/O | 2 | P138 | G14 | K22 | 923 |
| I/O | 2 | P139 | G15 | J21 | 926 |

XC2S200 Device Pinouts (Continued)

| XC2S200 Pad | l Name | | | | Bndry |
|-----------------------|--------|-------|-----------------------------|-----------------------------|-------|
| Function | Bank | PQ208 | FG256 | FG456 | Scan |
| I/O | 2 | - | - | K18 | 929 |
| I/O | 2 | - | - | J20 | 932 |
| I/O | 2 | P140 | G12 | J18 | 935 |
| GND | - | - | GND* | GND* | - |
| I/O | 2 | - | F16 | J22 | 938 |
| I/O | 2 | - | - | J19 | 941 |
| I/O | 2 | - | - | H21 | 944 |
| I/O | 2 | P141 | G13 | H19 | 947 |
| I/O (D2) | 2 | P142 | F15 | H20 | 950 |
| V _{CCINT} | - | P143 | V _{CCINT} * | V _{CCINT} * | - |
| V _{CCO} | 2 | P144 | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| GND | - | P145 | GND* | GND* | - |
| I/O (D1) | 2 | P146 | E16 | H22 | 953 |
| I/O, V _{REF} | 2 | P147 | F14 | H18 | 956 |
| I/O | 2 | - | - | G21 | 962 |
| I/O | 2 | P148 | D16 | G18 | 965 |
| GND | - | - | GND* | GND* | - |
| I/O | 2 | - | F12 | G20 | 968 |
| I/O | 2 | - | - | G19 | 971 |
| I/O | 2 | - | - | F22 | 974 |
| I/O | 2 | P149 | E15 | F19 | 977 |
| I/O, V _{REF} | 2 | P150 | F13 | F21 | 980 |
| V _{CCO} | 2 | - | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |
| GND | - | - | GND* | GND* | - |
| I/O | 2 | P151 | E14 | F20 | 983 |
| I/O | 2 | - | C16 | F18 | 986 |
| GND | - | - | GND* | GND* | - |
| I/O | 2 | - | - | E22 | 989 |
| I/O | 2 | - | - | E21 | 995 |
| I/O, V _{REF} | 2 | P152 | E13 | D22 | 998 |
| GND | - | - | GND* | GND* | - |
| I/O | 2 | - | B16 | E20 | 1001 |
| I/O | 2 | - | - | D21 | 1004 |
| I/O | 2 | - | - | C22 | 1007 |
| I/O (DIN, D0) | 2 | P153 | D14 | D20 | 1013 |
| I/O (DOUT, BUSY) | 2 | P154 | C15 | C21 | 1016 |
| CCLK | 2 | P155 | D15 | B22 | 1019 |
| V _{CCO} | 2 | P156 | V _{CCO} Bank 2* | V _{CCO} Bank 2* | - |